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Applicant(s)/Patent under Reexamination

10/634,116 Examiner JONES ET AL.

Djenane M. Bayard

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	SEAR	CHED	
Class	Subclass	Date	Examiner
709	227	9/12/2006	DB
709	217	9/12/2006	DB
709	222	9/12/2006	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
709	227	9/12/2006	DB	
709	217	9/12/2006	DB	
709	222	9/12/2006	DB	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East	9/12/2006	DB
Consulted with L. Donaghue	9/12/2006	DB